

UNITED STATES PATENT AND TRADEMARK OFFICE
CERTIFICATE OF CORRECTION

PATENT NO. : 6,975,552 B2
APPLICATION NO. : 10/644610
DATED : December 13, 2005
INVENTOR(S) : Tae H. Kim

Page 1 of 2

It is certified that error appears in the above-identified patent and that said Letters Patent is hereby corrected as shown below:

<u>Column, Line</u>	<u>Reads</u>	<u>Should Read</u>
Item (57), Line 3	"and an open line"	--and open line--
Column 1, Lines 45, 50 and 52	"complimentary"	--complementary--
Column 2, Line 40	"pair is surrounded"	--pair being surrounded--
Column 4, Line 30	"to which portion of a digit line memory cells are"	--to which portions of a digit line of memory cells are--
Column 4, Line 41	"aspects of a open digit line"	--aspects of an open digit line--
Column 4, Line 64	"array 10, thus, coupling"	--array 10, thus coupling--
Column 5, Line 57	"memory arrays, thus,"	--memory arrays, thus--
Column 5, Line 59	"to active column 50, 80"	--to active columns 50, 80--
Column 6, Line 27	"but are instead, shifted"	--but are instead shifted--
Column 6, Line 41	"are desired. For example,"	--are desired; for example,--

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Column 6, Line 66	"MDL portion 156 . virtue of the data state stored by the"	--MDL portion 156 . Consequently, the voltage of the digit line will be altered from the precharge voltage by virtue of the data state stored by the--
Column 7, Line 38	"of the memory arrays 202a , 202b is a respective row various"	--of the memory arrays 202a , 202b is a respective row address latch 226 , which stores the row address, and a row decoder 228 which applies various--
Column 14, Line 21	"cells of the column"	--cells of the column--

Signed and Sealed this

Twenty-fifth Day of December, 2007



JON W. DUDAS
Director of the United States Patent and Trademark Office